


<b>Search Notes</b>  	<b>Application/Control No.</b>  10784525	<b>Applicant(s)/Patent Under Reexamination</b>  HAPKE, KENYON A.
	<b>Examiner</b>  JASON P RIGGLEMAN	<b>Art Unit</b>  1792

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (USPAT, USPG-PUB, EPO, JPO, DERWENT, USOCR, FPRS) see updated @pd>20071115 search printout.	5/27/2008	JPR

INTERFERENCE SEARCH			
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